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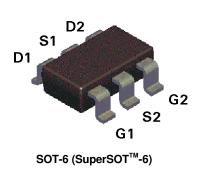
Dual N-Channel Enhancement Mode Field Effect Transistor

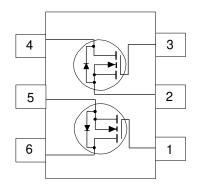
General Description

These dual N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process has been designed to minimize on-state resistance, provide rugged and reliable performance and fast switching. These devices is particularly suited for low voltage applications requiring a low current high side switch.

Features

- 0.51A, 50V, $R_{DS(ON)} = 2\Omega$ @ $V_{GS} = 10V$
- High density cell design for low R_{DS(ON)}.
- Proprietary SuperSOTTM-6 package design using copper lead frame for superior thermal and electrical capabilities.
- High saturation current.





Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		NDC7002N	Units
V _{DSS}	Drain-Source Voltage		50	V
V _{GSS}	Gate-Source Voltage - Continuous		20	V
I _D	Drain Current - Continuous	(Note 1a)	0.51	А
	- Pulsed		1.5	
P_{D}	Maximum Power Dissipation	(Note 1a)	0.96	W
		(Note 1b)	0.9	
		(Note 1c)	0.7	
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to 150	°C
THERMA	L CHARACTERISTICS			
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	130	°C/W
R _{eJC}	Thermal Resistance, Junction-to-Case	(Note 1)	60	°C/W

Symbol	Parameter	Conditions		Min	Тур	Max	Units
OFF CHA	RACTERISTICS				•		•
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$		50			V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$				1	μΑ
			T _J = 125°C			500	
I _{GSSF}	Gate - Body Leakage, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$	V _{GS} = 20 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate - Body Leakage, Reverse	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
ON CHAI	RACTERISTICS (Note 2)						
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		1	1.9	2.5	V
			T _J = 125°C	0.8	1.5	2.2	
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, \ I_D = 0.51 \text{ A}$			1	2	Ω
			T _J = 125°C		1.7	3.5	
		$V_{GS} = 4.5 \text{ V}, I_D = 0.35 \text{ A}$			1.6	4	
I _{D(on)}	On-State Drain Current	V _{GS} = 10 V, V _{DS} = 10 V		1.5			Α
g _{FS}	Forward Transconductance	$V_{DS} = 10 \text{ V}, I_{D} = 0.51 \text{ A}$			400		mS
DYNAMI	CHARACTERISTICS	<u></u>					
C _{iss}	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1.0 \text{ MHz}$			20		pF
C _{oss}	Output Capacitance				13		pF
C_{rss}	Reverse Transfer Capacitance				5		pF
SWITCHI	NG CHARACTERISTICS (Note 2)						
t _{D(on)}	Turn - On Delay Time	$V_{DD} = 25 \text{ V}, \ I_D = 0.25 \text{ A},$ $V_{GS} = 10 \text{ V}, R_{GEN} = 25 \Omega$			6	20	nS
t _r	Tum - On Rise Time				6	20	-
$t_{D(off)}$	Turn - Off Delay Time				11	20	
t _f	Turn - Off Fall Time				5	20	
Q _g	Total Gate Charge	$V_{DS} = 25 \text{ V},$ $I_{D} = 0.51 \text{ A}, V_{GS} = 10 \text{ V}$			1		nC
$\overline{Q_{gs}}$	Gate-Source Charge				0.19		nC
Q_{gd}	Gate-Drain Charge				0.33		nC

ELECTRICAL CHARACTERISTICS (T _A = 25°C unless otherwise noted)							
Symbol	Parameter Conditions		Min	Тур	Max	Units	
DRAIN-SOURCE DIODE CHARACTERISTICS							
Is	Maximum Continuous Source Current				0.51	Α	
I _{SM}	Maximum Pulse Source Current (Note 2)				1.5	Α	
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 0.51 \text{ A (Note 2)}$		0.8	1.2	V	

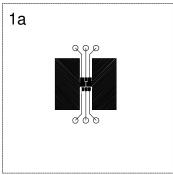
Notes:

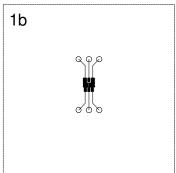
1. $R_{g,N}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{g,O}$ is guaranteed by design while $R_{g,O}$ is determined by the user's board design.

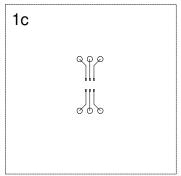
$$P_D(t) = \frac{T_J - T_A}{R_{\theta J} \, \hat{A}(t)} = \frac{T_J - T_A}{R_{\theta J} \, \hat{c}^\dagger R_{\theta C} \hat{A}(t)} = I_D^2(t) \times R_{DS(CN)} \hat{e}_{TJ}$$

Typical $R_{g,x}$ for single device operation using the board layouts shown below on 4.5"x5" FR-4 PCB in a still air environment:

- a. 130°C/W when mounted on a $0.125~\text{in}^2$ pad of 2oz cpper.
- b. 140°C/W when mounted on a 0.005 in 2 pad of 2oz cpper.
- c. 180°C/W when mounted on a 0.0015 in 2 pad of 2oz cpper.







Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width $\leq 300 \mu \text{s}, \, \text{Duty Cycle} \leq 2.0 \%.$

Typical Electrical Characteristics

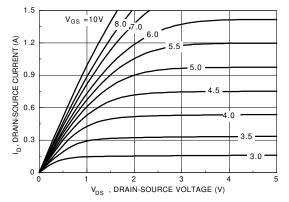


Figure 1. On-Region Characteristics.

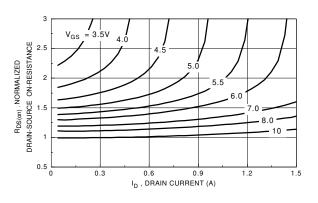


Figure 2. On-Resistance Variation with Gate Voltage and Drain Current.

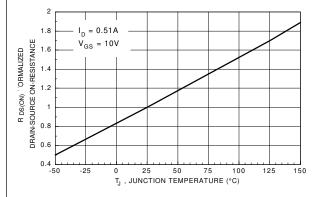


Figure 3. On-Resistance Variation with Temperature.

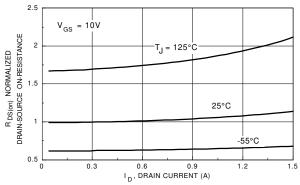


Figure 4. On-Resistance Variation with Drain Current and Temperature.

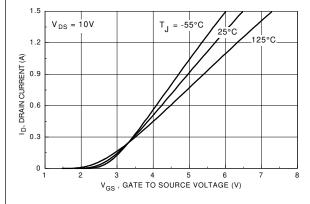


Figure 5. Transfer Characteristics.

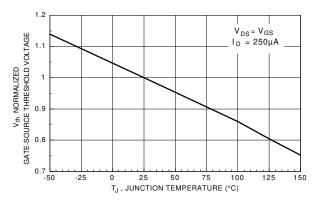


Figure 6. Gate Threshold Variation with Temperature.

Typical Electrical Characteristics (continued)

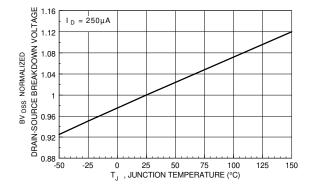


Figure 7. Breakdown Voltage Variation with Temperature.

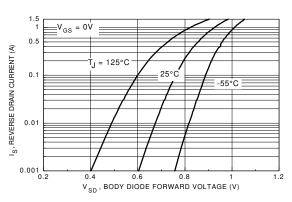


Figure 8. Body Diode Forward Voltage Variation with Current and Temperature.

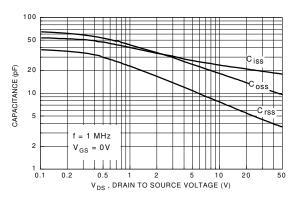


Figure 9. Capacitance Characteristics.

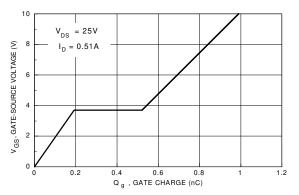


Figure 10. Gate Charge Characteristics.

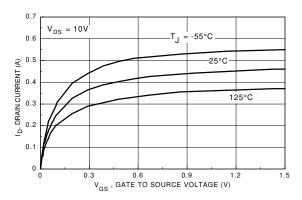


Figure 11. Transconductance Variation with Drain Current and Temperature.

Typical Thermal Characteristics

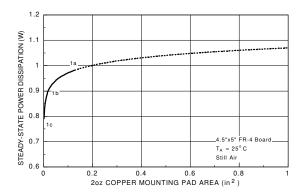


Figure 12. SOT-6 Dual Package Maximum Steady-State Power Dissipation versus Copper Mounting Pad Area.

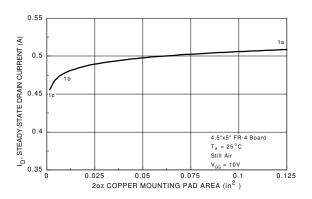


Figure 13. Maximum Steady-State Drain
Current versus Copper Mounting Pad
Area

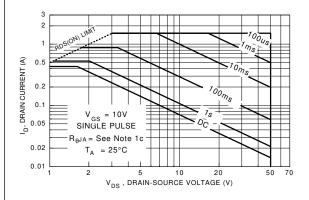


Figure 14. Maximum Safe Operating Area.

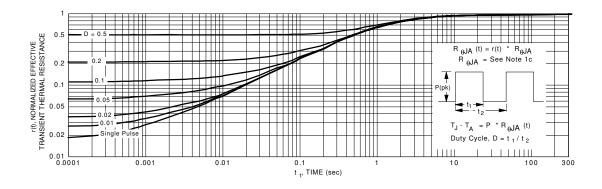


Figure 15. Transient Thermal Response Curve.

Note: Thermal characterization performed using the conditions described in note 1c. Transient thermal response will change depending on the circuit board design.

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